(12) INTERNATIONAL APPLICATION PUBLISHED UNDER THE PATENT COOPERATION TREATY (PCT)

(19) World Intellectual Property Organization

International Bureau





(10) International Publication Number WO 2015/071671 A1

(43) International Publication Date 21 May 2015 (21.05.2015)

(51) International Patent Classification: **C01G 15/00** (2006.01) H01L 31/032 (2006.01) B82Y 30/00 (2011.01) H01L 31/0352 (2006.01) C01B 19/00 (2006.01) H01L 31/0749 (2012.01)

(21) International Application Number:

PCT/GB2014/053371

(22) International Filing Date:

H01L 31/00 (2006.01)

13 November 2014 (13.11.2014)

H01L 31/0445 (2014.01)

(25) Filing Language:

English

(26) Publication Language:

English

(30) Priority Data:

61/904,780 15 November 2013 (15.11.2013)

US

FIG. 1

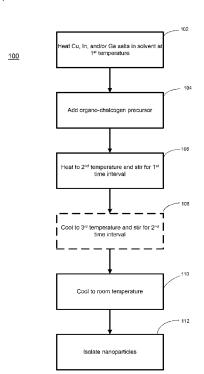
- **NANOCO TECHNOLOGIES** LTD (71) Applicant: [GB/GB]; 46 Grafton Street, Manchester M13 9NT (GB).
- (72) Inventors: NEWMAN, Christoper; Sycamores, 35 Liphill Bank Road, Holmfirth, West Yorkshire HD9 2LQ (GB). MASALA, Ombretta; 174 Birchfields Road, Fallowfield, Manchester M14 6PE (GB). KIRKHAM, Paul; 5 Bottoms Row, Cowpe, Rossentdale, Lancashire BB4 7EG (GB). ALLEN, Cary; 29 Wintermans Road, Manchester M21

7GE (GB). WHITELEGG, Stephen; 48 Marina Road, Bredbury, Stockport SK6 2PR (GB).

- Agent: MARKS & CLERK LLP; 1 New York Street, Manchester, Greater M M1 4HD (GB).
- (81) Designated States (unless otherwise indicated, for every kind of national protection available): AE, AG, AL, AM, AO, AT, AU, AZ, BA, BB, BG, BH, BN, BR, BW, BY, BZ, CA, CH, CL, CN, CO, CR, CU, CZ, DE, DK, DM, DO, DZ, EC, EE, EG, ES, FI, GB, GD, GE, GH, GM, GT, HN, HR, HU, ID, IL, IN, IR, IS, JP, KE, KG, KN, KP, KR, KZ, LA, LC, LK, LR, LS, LU, LY, MA, MD, ME, MG, MK, MN, MW, MX, MY, MZ, NA, NG, NI, NO, NZ, OM, PA, PE, PG, PH, PL, PT, QA, RO, RS, RU, RW, SA, SC, SD, SE, SG, SK, SL, SM, ST, SV, SY, TH, TJ, TM, TN, TR, TT, TZ, UA, UG, US, UZ, VC, VN, ZA, ZM, ZW.
- (84) Designated States (unless otherwise indicated, for every kind of regional protection available): ARIPO (BW, GH, GM, KE, LR, LS, MW, MZ, NA, RW, SD, SL, ST, SZ, TZ, UG, ZM, ZW), Eurasian (AM, AZ, BY, KG, KZ, RU, TJ, TM), European (AL, AT, BE, BG, CH, CY, CZ, DE, DK, EE, ES, FI, FR, GB, GR, HR, HU, IE, IS, IT, LT, LU, LV, MC, MK, MT, NL, NO, PL, PT, RO, RS, SE, SI, SK,

[Continued on next page]

(54) Title: PREPARATION OF COPPER-RICH COPPER INDIUM (GALLIUM) DISELENIDE/DISULFIDE NANOPARTICLES



(57) Abstract: A method for the preparation of copper indium gallium diselenide/disulfide (CIGS) nanoparticles utilizes a copper-rich stoichiometry. The copper-rich CIGS nanoparticles are capped with organo-chalcogen ligands, rendering the nanoparticles processable in organic solvents. The nanoparticles may be deposited on a substrate and thermally processed in a chalcogen-rich atmosphere to facilitate conversion of the excess copper to copper selenide or copper sulfide that may act as a sintering flux to promote liquid phase sintering and thus the growth of large grains. The nanoparticles so produced may be used to fabricate CIGS-based photovoltaic devices.

WO 2015/071671 A1

SM, TR), OAPI (BF, BJ, CF, CG, CI, CM, GA, GN, GQ, GW, KM, ML, MR, NE, SN, TD, TG).

before the expiration of the time limit for amending the claims and to be republished in the event of receipt of amendments (Rule 48.2(h))

Published:

— with international search report (Art. 21(3))

TITLE OF THE INVENTION: Preparation of Copper-Rich Copper Indium (Gallium) Diselenide/Disulfide Nanoparticles

CROSS-REFERENCE TO RELATED APPLICATIONS:

[0001] This application claims the benefit of U.S. Provisional Application No. 61/904,780 filed on November 15, 2013.

STATEMENT REGARDING FEDERALLY SPONSORED RESEARCH OR DEVELOPMENT: Not Applicable

BACKGROUND OF THE INVENTION

1. Field of the Invention.

[0002] The present invention generally relates to materials for photovoltaic cells. More particularly, it relates to a method for preparing copper indium gallium diselenide/disulfide (CIGS) nanoparticles. The invention further relates to CIGS-based devices formed from nanoparticle-based precursor inks.

2. <u>Description of the Related Art including information disclosed under 37 CFR</u> 1.97 and 1.98.

[0003] For commercial viability, photovoltaic (PV) cells must generate electricity at a competitive cost to fossil fuels. To meet these costs, the PV cells must comprise low cost materials along with an inexpensive device fabrication process and with moderate to high conversion efficiency of sunlight to electricity. For a device-building method to succeed, the materials synthesis and device fabrication must be commercially scalable.

[0004] The current photovoltaic market remains dominated by silicon wafer-based solar cells (first-generation solar cells). However, the active layer in these solar cells is made of silicon wafers having a thickness ranging from microns to hundreds of microns because silicon is a relatively poor absorber of light. These single-crystal wafers are very expensive to produce because the process

involves fabricating and slicing high-purity, single-crystal silicon ingots, and is also very wasteful.

[0005] The high cost of crystalline silicon wafers has led the industry to look at cheaper materials to make solar cells and for this reason much development work has focused on producing high efficiency thin film solar cells where material costs are significantly reduced compared to silicon.

[0006] Semiconductor materials like copper indium gallium diselenides and disulfides (Cu(In,Ga)(S,Se)₂, herein referred to as "CIGS") are strong light absorbers and have band gaps that match well with the optimal spectral range for PV applications. Furthermore, because these materials have strong absorption coefficients, the active layer in the solar cell is required to be only a few microns thick.

Copper indium diselenide (CuInSe₂) is one of the most promising candidates for thin-film PV applications due to its unique structural and electrical properties. Its band gap of 1.0 eV is well matched with the solar spectrum. CuInSe₂ solar cells can be made by the selenization of CuInS₂ films because, during the selenization process, Se replaces S and the substitution creates volume expansion, which reduces void space and reproducibly leads to high-quality, dense, CuInSe₂ absorber layers. [Q. Guo, G.M. Ford, H.W. Hillhouse and R. Agrawal, *Nano Lett.*, 2009, **9**, 3060] Assuming complete replacement of S with Se, the resulting lattice volume expansion is ~14.6 %, which is calculated based on the lattice parameters of chalcopyrite (tetragonal) CuInS₂ (a = 5.52 Å, c = 11.12 Å) and CuInSe₂ (a = 5.78 Å, c = 11.62 Å). This means that the CuInS₂ nanocrystal film can be easily converted to a predominantly selenide material, by annealing the film in a selenium-rich atmosphere. Therefore, CuInS₂ is a promising alternative precursor for producing CuInSe₂ or CuIn(S,Se)₂ absorber layers.

[0007] The theoretical optimum band gap for absorber materials is in the region of 1.2 - 1.4 eV. By incorporating gallium into CuIn(S,Se)₂ nanoparticles, the band gap can be manipulated such that, following selenization, a

Cu_xIn_yGa_zS_aSe_b absorber layer is formed with an optimal band gap for solar absorption.

[0008] Conventionally, costly vapor phase or evaporation techniques (for example metal-organic chemical vapor deposition (MO-CVD), radio frequency (RF) sputtering, and flash evaporation) have been used to deposit CIGS films on a substrate. While these techniques deliver high-quality films, they are difficult and expensive to scale to larger-area deposition and higher process throughput.

[0009] One of the major advantages of using nanoparticles of CIGS is that they can be dispersed in a medium to form an ink that can be printed on a substrate in a similar way to inks in a newspaper-like process. The nanoparticle ink or paste can be deposited using low-cost printing techniques such as spin coating, slit coating and doctor blading. Printable solar cells could replace the standard conventional vacuum-deposited methods of solar cell manufacture because the printing processes, especially when implemented in a roll-to-roll processing framework, enables a much higher throughput.

[0010] The synthetic methods developed so far offer limited control over the particle morphology, and particle solubility is usually poor which makes ink formulation difficult.

[0011] The challenge is to produce nanoparticles that overall are small, have a low melting point, narrow size distribution and incorporate a volatile capping agent, so that they can be dispersed in a medium and the capping agent can be eliminated easily during the film baking process. Another challenge is to avoid the inclusion of impurities, either from synthetic precursors or organic ligands that could compromise the overall efficiency of the final device. The applicant's copending U.S. patent applications published as Nos. 2009/0139574 and 2014/0249324 describe the scalable synthesis of CIGS nanoparticles capped with organo-chalcogen ligands for use as precursors for the formation of photovoltaic devices, and are hereby incorporated by reference in their entireties.

[0012] One of the challenges associated with the nanoparticle-based CIGS deposition approach is to achieve large grains after thermal processing. Grain sizes on the order of the film thickness are desirable since grain boundaries act as electron-hole recombination centers.

[0013] Elemental dopants, such as sodium [R. Kimura, T. Mouri, N. Takuhai, T. Nakada, S. Niki, A. Yamada, P. Fons, T. Matsuzawa, K. Takahashi and A. Kunioka, *Jpn. J. Appl. Phys.*, 1999, **38**, L899] and antimony, [M. Yuan, D.B. Mitzi, W. Liu, A.J. Kellock, S.J. Chey and V.R. Deline, *Chem. Mater.*, 2010, **22**, 285] have been reported to enhance the grain size of CIGS films and thus the power conversion efficiency (PCE) of the resulting devices.

[0014] In another approach, a binary copper chalcogenide compound is added the CIGS precursor(s) to promote grain growth. Copper chalcogenide compounds with a lower melting point than CIGS can act as a sintering flux to promote grain growth of the CIGS layer at a temperature well-below its melting point. It is thought that, at the sintering temperature, the sintering flux is a liquid that wets the CIGS grains such that they dissolve in the liquid. This is believed to promote particle bonding, leading to higher densification rates and lower sintering temperatures, and is referred to as "liquid phase sintering."

[0015] Casteleyn *et al.* studied the influence of Cu, CuSe, Cu₂Se and Se additives on CuInSe₂ films. [M. Casteleyn, M. Burgelman, B. Depuydt, A. Niemegeers and I. Clemminck, *IEEE First World Conference on Photovoltaic Energy Conversion*, 1994, **1**, 230]. It was found that, in a selenium-rich atmosphere, Cu-rich phases formed CuSe, which acted as a flux above its melting point (523°C) to promote liquid phase sintering and thus promote grain growth.

[0016] Kim *et al.* applied a layer of sputtered Cu₂Se onto the surface of a sputtered Cu-In-Ga film that was subsequently selenised to form a CIGS layer. [M.S. Kim, R.B.V. Chalapathy, K.H. Yoon and B.T. Ahn, *J. Electrochem Soc.*,

2010, **157**, B154] Cu_2Se was found to promote grain growth when the overall Cu/(In + Ga) ratio was greater than 0.92.

[0017] Cu₂S powder (melting point: 435 °C) has been added to Cu₂In₂O₅ nanoparticles prior to sulfurization, to promote the conversion to chalcopyrite CuInS₂ and facilitate grain growth. [C.-Y. Su, D.K. Mishra, C.-Y. Chiu and J.-M. Ting, *Surf. Coat. Technol.*, 2013, **231**, 517]

[0018] The applicant's co-pending US patent application number 61/847,639 describes the preparation of copper selenide nanoparticles, which can be added to CIGS materials as a flux to promote grain growth. The nanoparticle melting point is lower than that of the corresponding bulk copper selenide phase, enabling copper selenide nanoparticles to effect liquid phase sintering at a reduced temperature.

[0019] In the prior art methods to promote grain growth using binary copper chalcogenide precursors, a pre-fabricated copper chalcogenide compound is employed. Thus, there is a need for a method to form the copper chalcogenide phase *in situ*, to reduce the processing requirements associated with the formation of a CIGS film with large grains. Herein, a method is described to enhance the grain size of CIGS films using a nanoparticle-based deposition approach, wherein the CIGS nanoparticles are copper-rich. The nanoparticles can be processed in a chalcogen-rich atmosphere to facilitate conversion of the excess copper to copper selenide or copper sulfide that acts as a sintering flux to promote liquid phase sintering and thus the growth of large grains. The stoichiometry of the resulting CIGS absorber layer can be controlled by both the nanoparticle stoichiometry and post-annealing processing steps, such as KCN etching.

BRIEF SUMMARY OF THE INVENTION

[0020] In certain embodiments, the present invention comprises a method for the synthesis of copper-rich CIGS nanoparticles. The copper-rich CIGS

nanoparticles are capped with organo-chalcogen ligands, rendering the nanoparticles processable in organic solvents. The nanoparticles may be deposited on a substrate and thermally processed in a chalcogen-rich atmosphere to facilitate conversion of the excess copper to copper selenide or copper sulfide that may act as a sintering flux to promote liquid phase sintering and thus the growth of large grains. The stoichiometry of the resulting CIGS absorber layer can be controlled by both the nanoparticle stoichiometry and post-annealing processing steps, such as KCN etching, which may be employed to selectively eliminate excess binary copper chalcogenide phases. The CIGS absorber layer may subsequently be incorporated into a photovoltaic device.

BRIEF DESCRIPTION OF THE SEVERAL VIEWS OF THE DRAWING(S)

[0021] FIG. 1 is a flow chart showing a first method of preparing Cu-rich CIGS nanoparticles according to certain embodiments of the invention.

[0022] FIG. 2 is a flow chart showing a second method of preparing Cu-rich CIGS nanoparticles according to certain embodiments of the invention.

[0023] FIG. 3 is a flow chart showing a method of preparing a photovoltaic device using Cu-rich CIGS nanoparticles, according to certain embodiments of the invention.

[0024] FIG. 4 compares the X-ray diffraction pattern, 401, of a CIGS film prepared with Cu-rich CIGS nanoparticles according to the Examples, to that of a CIGS film prepared with near-stoichiometric CIGS nanoparticles, 402.

[0025] FIG. 5 is a scanning electron microscopy image of a CIGS film prepared from Cu-rich CIGS nanoparticles prepared according to the Examples.

DETAILED DESCRIPTION OF THE INVENTION

[0026] Herein, a method for the preparation of CIGS nanoparticles is described. Processing of the nanoparticles to form an ink, which can be

deposited to form a CIGS-based film, and subsequent processing to form a PV device, is also described. During device processing, excess copper in the nanoparticles may react with a chalcogen source to form a binary chalcogenide that acts as a flux to facilitate liquid phase sintering of the CIGS layer. The term "CIGS" should herein be understood to describe any material of the form $Cu_xIn_yGa_zS_aSe_b$. Typically, $x \approx y + z \approx 1$, and $a + b \approx 2$, but the material need not be stoichiometric. For example, in some embodiments, CIGS nanoparticles are described where x > y + z.

[0027] During device processing, excess copper in the nanoparticles reacts with a chalcogen source to form one or more binary chalcogenide phases *in situ* that may act as a sintering flux that facilitates the growth of large grains. The chalcogen source with which the excess copper reacts may be provided by the nanoparticles (e.g., from the organo-chalcogen capping ligand) and/or by an external chalcogenization process, such as selenization.

[0028] In a first embodiment, nanoparticles of the form $Cu_xIn_yGa_zS_a$ are prepared, where x > y + z, and a ≈ 2 , and including doped derivatives thereof. The nanoparticles are capped with one or more organo-thiol ligands, for example 1-octanethiol.

[0029] In a second embodiment, nanoparticles of the form $Cu_xIn_yGa_zSe_b$ are prepared, where x > y + z, and $b \approx 2$, and including doped derivatives thereof. The nanoparticles are capped with one or more organo-selenol ligands, for example 1-octane selenol.

[0030] In a third embodiment, nanoparticles of the form $Cu_xIn_yGa_zS_aSe_b$ are prepared, where x > y + z, and $a + b \approx 2$, and including doped derivatives thereof. The nanoparticles are capped with one or more organo-thiol and/or organo-selenol ligands, for example 1-octanethiol, 1-octane selenol, *etc.*

[0031] According to certain embodiments of the invention, a first method to prepare Cu-rich CIGS nanoparticles is as follows (with reference numbers to flowchart 100 of Figure 1):

- a) Heat Cu, In and/or Ga salts in a solvent at a first temperature (102).
- **b)** Add an organo-chalcogen precursor (104).
- c) Heat the reaction solution to a second temperature and stir for a first time interval (106).
- **d)** Optionally, cool the reaction solution to a third temperature and stir for a second time interval (108).
- e) Cool the reaction solution to room temperature (110).
- f) Isolate the nanoparticles (112).

[0032] The Cu, In and Ga salts may include, but are not restricted to, acetates, acetylacetonates, and halides, e.g. chlorides, bromides, iodides. The relative ratio of the salts is used to control the stoichiometry of the resulting nanoparticles. One skilled in the art will realize that the molar ratio of the precursor salts to be added depends on both the desired nanoparticle stoichiometry and the relative reactivity of the precursors. In certain preferred embodiments, the molar ratio of Cu salts to the combined total of In and Ga salts is between about 1:0.65 and about 1:0.85.

[0033] The Cu, In and Ga salts are combined in a solvent. In some embodiments, the solvent is a non-coordinating solvent. Examples include, but are not restricted to, 1-octadecene, benzylether, diphenylether, and heat transfer fluids (e.g., Therminol® 66).

[0034] The Cu, In and Ga salts are heated in the solvent to a first temperature. In some embodiments, the first temperature lies between room temperature and 150 °C, for example 100 °C.

[0035] An organo-chalcogen precursor is added to the reaction mixture at the first temperature. The organo-chalcogen precursor acts as both a chalcogen source and a ligand that caps the nanoparticle surface to provide solubility. In some embodiments, the organo-chalcogen precursor may have a boiling point below around 250 °C to facilitate its removal from the surface of the nanoparticles during device processing. This is desirable, since carbon residues remaining in the CIGS layer prior to processing can have a detrimental effect on device performance. Suitable organo-chalcogen precursors may be of the form R-X-H, where R is an alkyl or aryl group and X is S or Se. Examples include, but are not restricted to, 1-octanethiol, 1-octane selenol, and 1-dodecane selenol.

[0036] Following the addition of the organo-chalcogen precursor, the reaction solution is heated to a second temperature and stirred for a first time interval. In some embodiments, the second temperature is higher than the first temperature. For example, the second temperature may fall in the range $160 - 240 \,^{\circ}$ C, more particularly around $200 \,^{\circ}$ C In certain embodiments, the first time interval ranges from 30 minutes - 10 hours, more particularly around 2 - 6 hours.

[0037] Optionally, the reaction solution is cooled to a third temperature below that of the second temperature and the reaction solution is annealed for a second time interval, for example around 4 - 24 hours, more particularly around 18 hours.

[0038] After cooling to room temperature, the nanoparticles are isolated from the reaction solution. The nanoparticles may be isolated by any method known in the prior art, such as the addition of one or more solvents to precipitate the nanoparticles from solution, followed by collection via centrifugation or filtration. One skilled in the art will realize that the choice of solvent(s) to isolate the nanoparticles depends on the chemical nature of the solvent in which the nanoparticle synthesis is conducted.

[0039] According to certain embodiments, a second method to prepare Cu-rich CIGS nanoparticles is as follows (with reference numbers to flowchart 200 of Figure 2):

- a) Mix Cu, In and/or Ga salts in a solvent (202).
- **b)** Add an organo-chalcogen precursor (204).
- c) Heat the reaction solution to a first temperature and stir for a first time interval to distill any volatile by-products (206).
- **d)** Heat the reaction solution to a second temperature and add a second chalcogen precursor over a second time interval (208).
- e) Stir the reaction solution at the second temperature for a third time interval (210).
- f) Cool the reaction solution to a third temperature and stir for a fourth time interval (212).
- **g)** Cool the reaction solution to room temperature (214).
- h) Isolate the nanoparticles (216).

[0040] The Cu, In and Ga salts may include, but are not restricted to, acetates, acetylacetonates, and halides, e.g., chlorides, bromides, iodides. The relative ratio of the salts is used to control the stoichiometry of the resulting nanoparticles. One skilled in the art will realize that the molar ratio of the precursor salts to be added depends on both the desired nanoparticle stoichiometry and the relative reactivity of the precursors.

[0041] The Cu, In and Ga salts are combined in a solvent. In some embodiments, the solvent is a non-coordinating solvent. Examples include, but are not restricted to, 1-octadecene, benzylether, diphenylether, and heat transfer fluids such as Therminol® 66 (Solutia, Inc., St. Louis, Missouri 63141).

[0042] An organo-chalcogen precursor is added to the reaction mixture. The organo-chalcogen precursor acts as both a chalcogen source and a ligand that caps the nanoparticle surface to provide solubility. In some embodiments, the organo-chalcogen precursor may have a boiling point below around 250 °C to facilitate its removal from the surface of the nanoparticles during device

processing. This is desirable, since carbon residues remaining in the CIGS layer prior to processing can have a detrimental effect on device performance. Suitable organo-chalcogen precursors may be of the form R-X-H, where R is an alkyl or aryl group and X is S or Se. Examples include, but are not restricted to, 1-octanethiol, 1-octane selenol, and 1-dodecane selenol.

[0043] Following the addition of the organo-chalcogen precursor, the reaction solution is heated to a first temperature and stirred for a first time interval to distill any volatile by-products. One skilled in the art will recognize that the first temperature depends on the chemical nature of the metal precursor salts and the boiling point(s) of the by-product(s) thus formed. For example, an organo-chalcogen precursor may react with metal acetate salts to form acetic acid as a by-product; the acetic acid can be distilled at a first temperature above its boiling point $(117 - 118 \, ^{\circ}\text{C})$. The first time interval should be sufficient to effect the distillation of all of the volatile by-product(s). In some embodiments, the first time interval is 30 minutes.

[0044] The reaction solution is subsequently heated to a second temperature, at which a second chalcogen precursor is added over a second time interval. In certain embodiments, the second temperature lies in the range 120 − 160 °C, for example 140 °C. In particular embodiments, the second chalcogen precursor is an elemental chalcogen dissolved in a coordinating solvent such as, but not restricted to, trioctylphosphine sulfide (TOP/S) or trioctylphosphine selenide (TOP/Se). The second chalcogen precursor may be added drop wise, for example at a rate of 0.5 mmol − 1 mol per minute, more particularly around 1 − 10 mmol per minute, for example around 1.4 mmol per minute.

[0045] The reaction solution is stirred at the second temperature for a third time interval. In some embodiments, the third time interval lies in the range 30 minutes – 2 hours, for example around 1 hour.

[0046] The reaction solution is cooled to a third temperature below that of the second temperature, then stirred for a fourth time interval. In some embodiments, the third temperature lies in the range $80 - 120 \,^{\circ}$ C, for example around $90 \,^{\circ}$ C. In

certain embodiments, the fourth time interval is between 3 to 6 hours, for example 4½ hours.

[0047] After cooling to room temperature, the nanoparticles are isolated from the reaction solution. The nanoparticles may be isolated by any method known in the prior art, such as the addition of one or more solvents to precipitate the nanoparticles from solution, followed by collection via centrifugation or filtration. One skilled in the art will realize that the choice of solvent(s) to isolate the nanoparticles depends on the chemical nature of the solvent in which the nanoparticle synthesis is conducted.

[0048] According to certain embodiments, a CIGS device is prepared from Curich nanoparticles as follows (with reference numbers to flowchart 300 of Figure 3):

- a) Dissolve/disperse nanoparticles in a solvent, to form an ink, A, (302).
- **b)** Deposit the ink, **A**, on a substrate to form a film (304).
- c) Anneal in an inert atmosphere (306).
- **d)** Repeat steps b) and c), until the annealed film reaches the desired thickness (309).
- **e)** Perform further film processing steps, e.g., annealing, sintering, selenization, KCN etching, as required (308).
- f) Deposit an *n*-type semiconductor layer to form a junction (310).
- g) Deposit intrinsic ZnO to form an extended depletion layer (312).
- h) Deposit a window layer (314).
- i) Deposit a metal grid (316).
- j) Encapsulate the device (318).

[0049] In particular embodiments, the nanoparticles are ternary, quaternary or quinary chalcogenides of the form $Culn_wGa_xSe_vS_z$, where $0 \le w$, x < 1, w + x < 1,

y, $z \ge 0$ and $y + z \approx 2$, including doped species, alloys and combinations thereof, but are not restricted to these, and can include non-stoichiometric derivatives thereof. In certain embodiments, $0.7 \le w + x < 1$, for example $0.7 \le w + x \le 0.8$. The nanoparticles must be soluble or dispersible in the solvent.

[0050] The solvent must be capable of dissolving or dispersing the nanoparticles. Those skilled in the art will realize that the choice of solvent depends on the surface coating of the nanoparticles, such as the chemical nature of the capping ligands. Preferably, the solvent is an organic solvent. A particular example is toluene, but other solvents known to those skilled in the art may be used, including, but not restricted to, alkanes (e.g., hexane), chlorinated solvents e.g., (dichloromethane, chloroform, etc.), ketones (e.g., isophorone), ethers (e.g., anisole), terpenes (e.g., α-terpinene, limonene, etc.), etc.

[0051] Optionally, further additives may be incorporated into the nanoparticle ink, for example to modify the coating properties such as the rheology. In some embodiments, oleic acid is added at a concentration between 2 - 5 wt. % of the total ink formulation.

[0052] Any suitable method may be used to deposit the nanoparticle ink, A. Examples include, but are not restricted to, spin coating, slit coating, doctor blading and inkjet printing.

[0053] The nanoparticle ink, **A**, may be deposited on any suitable substrate. Examples include, but are not restricted to, indium tin oxide (ITO), molybdenum-coated bare glass, and molybdenum-coated soda-lime glass (SLG).

[0054] In some embodiments, one or more anode buffer layers are deposited onto the substrate and processed, prior to the deposition of ink A. The anode buffer layer may, for example, be composed of CIGS nanoparticles with a stoichiometry differing to that of the nanoparticles used to formulate the ink A. In particular embodiments, the anode buffer layer is indium-rich, i.e. the ratio of Cu/In < 1. In certain embodiments, the thickness of each anode buffer layer is ≤ 100 nm, for example between 50 − 70 nm.

[0055] In particular embodiments, steps b) and c) are repeated until the CIGS film thickness is greater than or equal to 1 μ m. For example, the film thickness may lie in the range 1.0 – 2.0 μ m.

[0056] One skilled in the art will realize that the annealing temperature and time following the deposition of each CIGS layer will depend on the nature of the solvent and organic components of the ink formulation. In certain embodiments, the films are annealed at a first, lower temperature in the region of $250 - 300 \,^{\circ}$ C, for example around $270 \,^{\circ}$ C, for between 3 - 7 minutes, for example around 5 minutes, then the films are subsequently annealed at a second, higher temperature in the region of $400 - 430 \,^{\circ}$ C, for example around $415 \,^{\circ}$ C, for between 3 - 7 minutes, for example around 5 minutes.

[0057] In some embodiments, the film processing steps may comprise a sulfurization process, during which the CIGS film is annealed in a sulfur-rich atmosphere. Any suitable sulfur source may be used to provide the sulfur-rich atmosphere, such as a solid or liquid sulfur compound that can be vaporized, or a gaseous sulfur source. In a particular embodiment, the sulfur-rich atmosphere is provided by H_2S gas at a concentration of ≤ 10 %, for example 2-5 %, in an inert carrier gas such as, but not restricted to, N_2 .

[0058] The film processing steps comprise a selenization process, during which the CIGS film is annealed in a selenium-rich atmosphere. The selenization process may facilitate the conversion of the excess copper in the CIGS nanoparticles to copper selenide, forming a flux to facilitate liquid phase sintering and the growth of large grains. When using $Cu(In,Ga)S_2$ nanoparticles, the selenization process may also effect the partial or complete conversion of a $CuInS_2$ layer to $CuInSe_2$. Any suitable selenium source may be used to provide the selenium-rich atmosphere, such as a solid or liquid selenium compound that can be vaporized, or a gaseous selenium source. In a particular embodiment, the selenium-rich atmosphere is provided by H_2Se gas at a concentration of ≤ 10 %, for example 2-5 %, in an inert carrier gas such as, but not restricted to, N_2 .

[0059] The film processing steps may further comprise a KCN etch. Etching of the CIGS film in KCN solution can be used to selectively remove excess copper selenide and/or copper sulfide phases from the CIGS absorber layer. The etching process may be carried out in 5-15 % KCN solution, for example 10 % KCN solution, for a time period of 30 seconds -5 minutes, for example 3 minutes.

[0060] Any suitable *n*-type semiconductor layer may be deposited. Examples include, but are not restricted to, CdS, Zn(O,S), ZnO, and ZnS.

[0061] In some embodiments, the window layer consists of aluminum zinc oxide (AZO), but other transparent, conducting oxides known to those skilled in the art, such as indium tin oxide (ITO) and boron-doped zinc oxide (BZO) may be used.

[0062] An aspect of the present invention provides a method for preparing CIGS nanoparticles comprising: heating a copper salt together with at least one salt selected from the group consisting of indium salts and gallium salts in a solvent at a first temperature to produce a reaction solution; adding an organochalcogen precursor to the reaction solution; heating the reaction solution to a second temperature while stirring for a first time interval; cooling the reaction solution to room temperature; and, isolating nanoparticles from the reaction solution.

[0063] The molar ratio of Cu salts to the combined total of In and Ga salts may be between about 1:0.65 and about 1:0.85. The method may further comprise: cooling the reaction solution to a third temperature and stirring for a second time interval after heating the reaction solution to a second temperature. The group consisting of copper salts, indium salts and gallium salts may comprise salts selected from the group consisting of acetates, acetylacetonates, chlorides, bromides, and iodides. The solvent may be a non-coordinating solvent, which may be selected from the group consisting of 1-octadecene, benzylether, diphenylether and heat transfer fluids comprising hydrogenated terphenyls. The first temperature may be between room temperature and about 100 °C. The organo-chalcogen precursor may be of the form R-X-H, where R is an alkyl or

aryl group and X is sulfur or selenium. The organo-chalcogen precursor may be selected from the group consisting of 1-octanethiol, 1-octane selenol, and 1-dodecane selenol. The second temperature may be higher than the first temperature. The second temperature may be between about 160 °C and about 240 °C. The method may further comprise annealing the reaction solution at a temperature below the second temperature for a period between about 4 hours and about 24 hours. Isolating the nanoparticles may comprise precipitating the nanoparticles from solution by the addition of at least one other solvent.

[0064] Another aspect of the present invention provides CIGS nanoparticles prepared by the process comprising the steps of: heating a copper salt together with at least one salt selected from the group consisting of indium salts and gallium salts in a solvent at a first temperature to produce a reaction solution; adding an organo-chalcogen precursor to the reaction solution; heating the reaction solution to a second temperature while stirring for a first time interval; cooling the reaction solution to room temperature; and, isolating nanoparticles from the reaction solution.

[0065] The molar ratio of Cu salts to the combined total of In and Ga salts may be between about 1:0.65 and about 1:0.85. The preparation process may further comprise: cooling the reaction solution to a third temperature and stirring for a second time interval after heating the reaction solution to a second temperature.

[0066] Another aspect of the present invention provides a method for preparing CIGS nanoparticles comprising: mixing salts selected from the group consisting of copper salts, indium salts and gallium salts in a solvent at a first temperature to produce a reaction solution; adding an organo-chalcogen precursor to the reaction solution; heating the reaction solution to a first temperature while stirring for a first time interval; heating the reaction solution to a second temperature and adding a second chalcogen precursor over a second time interval; stirring the reaction solution at the second temperature for a third time interval; cooling the reaction solution to a third temperature and stirring for a

fourth time interval; cooling the reaction solution to room temperature; and, isolating the nanoparticles.

[0067] The molar ratio of Cu salts to the combined total of In and Ga salts may be between about 1:0.65 and about 1:0.85. The group consisting of copper salts, indium salts and gallium salts may comprise salts selected from the group consisting of acetates, acetylacetonates, chlorides, bromides, and iodides. The solvent may be a non-coordinating solvent, which may be selected from the group consisting of 1-octadecene, benzylether, diphenylether and heat transfer fluids comprising hydrogenated terphenyls. The organo-chalcogen precursor may be of the form R-X-H, where R is an alkyl or aryl group and X is sulfur or selenium. The organo-chalcogen precursor may have a boiling point below about 250 °C. The organo-chalcogen precursor may be selected from the group consisting of 1-octanethiol, 1-octane selenol, and 1-dodecane selenol. The first time interval may be sufficient to effect distillation of substantially all volatile byproducts. The second temperature may be between about 120 °C and about 160 ℃. The second chalcogen precursor may comprise an elemental chalcogen dissolved in a coordinating solvent, which solvent may be selected from the group consisting of trioctylphosphine sulfide and trioctylphosphine selenide. The second temperature may be between about 120 °C and about 160 °C. The third time interval may be between about 30 minutes about 2 hours. The third temperature may be between about 80 °C and about 120 °C. The fourth time interval may be between about 3 hours and about 6 hours. Isolating the nanoparticles may comprise precipitating the nanoparticles from solution by the addition of at least one other solvent.

[0068] Another aspect of the present invention provides CIGS nanoparticles prepared by the process comprising the steps of: mixing salts selected from the group consisting of copper salts, indium salts and gallium salts in a solvent at a first temperature to produce a reaction solution; adding an organo-chalcogen precursor to the reaction solution; heating the reaction solution to a first temperature while stirring for a first time interval; heating the reaction solution to a second temperature and adding a second chalcogen precursor over a second

time interval; stirring the reaction solution at the second temperature for a third time interval; cooling the reaction solution to a third temperature and stirring for a fourth time interval; cooling the reaction solution to room temperature; and, isolating the nanoparticles.

[0069] The molar ratio of Cu salts to the combined total of In and Ga salts is between about 1:0.65 and about 1:0.85.

[0070] A further aspect of the present invention provides a CIGS-based photovoltaic device prepared by the process comprising the steps of: mixing nanoparticles in a solvent to form an ink; depositing the ink on a substrate to form a film; annealing the film in an inert atmosphere to produce an annealed film; repeating steps b and c until the annealed film obtains a preselected thickness; depositing an *n*-type semiconductor layer on the annealed film to form a junction; depositing intrinsic ZnO on the junction to form an extended depletion layer; depositing a window layer on the extended depletion layer; depositing a metal grid on the window layer to form an assembly; and, encapsulating the assembly to form a photovoltaic device.

[0071] The process of preparation may further comprise: performing at least one further film processing step subsequent to step d selected from the group of film processing steps consisting of annealing, sintering, selenization, and etching with KCN. The nanoparticles may be selected from the group consisting of ternary, quaternary and quinary chalcogenides of the form $CuIn_wGa_xSe_yS_z$, where $0 \le w$, x < 1, w + x < 1, y, $z \ge 0$ and $y + z \approx 2$, including doped species, alloys and combinations thereof. Optionally, $0.7 \le w + x < 1$. The nanoparticles may be soluble in the solvent. The nanoparticles may be dispersible in the solvent. The solvent may be selected from the group consisting of toluene, alkanes, dichloromethane, chloroform, isophorone, anisole, α -terpinene and, limonene. The ink may additionally comprise oleic acid at a concentration between about 2 - 5 wt. % of the total ink formulation. The substrate may be selected from the group consisting of indium tin oxide (ITO), molybdenum-coated bare glass, and molybdenum-coated soda-lime glass (SLG). Steps b and c may

be repeated until the CIGS film thickness is at least 1 µm. At least one buffer layer may be deposited onto the substrate and processed prior to the deposition of the ink. The at least one buffer laver may comprise CIGS nanoparticles having a stoichiometry different from that of the nanoparticles used to formulate the ink. The ratio of copper to indium (Cu/In) may be less than one. The thickness of the buffer layer may be ≤ 100 nm. The film may be annealed at a first, lower temperature between about $250 \,^{\circ}\text{C} - 300 \,^{\circ}\text{C}$ for between about 3 - 7 minutes then subsequently annealed at a second, higher temperature between about 400 °C − $430 \,^{\circ}$ C for between about 3 – 7 minutes. The process of preparation may further comprise: performing at least one further film processing step subsequent to step d comprising a sulfurization process, during which the CIGS film is annealed in a sulfur-rich atmosphere. The sulfur-rich atmosphere may be provided by H₂S gas in an inert carrier gas. The process of preparation may further comprise: performing at least one further film processing step subsequent to step d comprising a selenization process, during which the CIGS film is annealed in a selenium-rich atmosphere. The selenium-rich atmosphere may be provided by H₂Se gas in an inert carrier gas. The selenization process may effect conversion of excess copper in the CIGS nanoparticles to copper selenide. The selenization process may also effect at least a partial conversion of a CulnS₂ layer to CulnSe₂. The process of preparation may further comprise etching of the CIGS film in a KCN solution to selectively remove excess copper selenide and/or copper sulfide phases from the CIGS absorber layer. The *n*-type semiconductor layer may comprise a material selected from the group consisting of CdS, Zn(O,S), ZnO and ZnS. The window layer may consist of a material selected from the group consisting of aluminum zinc oxide (AZO) and boron-doped zinc oxide. The window layer may consist of indium tin oxide (ITO). The nanoparticles may be nanoparticles according to the aspect of the present invention set out above which relates to CIGS nanoparticles prepared by the process comprising the steps of: heating a copper salt together with at least one salt selected from the group consisting of indium salts and gallium salts in a solvent at a first temperature to produce a reaction solution; adding an organo-chalcogen

precursor to the reaction solution; heating the reaction solution to a second temperature while stirring for a first time interval; cooling the reaction solution to room temperature; and, isolating nanoparticles from the reaction solution. The nanoparticles may be nanoparticles according to the aspect of the present set out above which relates to CIGS nanoparticles prepared by the process comprising the steps of: mixing salts selected from the group consisting of copper salts, indium salts and gallium salts in a solvent at a first temperature to produce a reaction solution; adding an organo-chalcogen precursor to the reaction solution; heating the reaction solution to a first temperature while stirring for a first time interval; heating the reaction solution to a second temperature and adding a second chalcogen precursor over a second time interval; stirring the reaction solution at the second temperature for a third time interval; cooling the reaction solution to a third temperature and stirring for a fourth time interval; cooling the reaction solution to room temperature; and, isolating the nanoparticles.

Examples

Example 1: Synthesis of Copper-Rich CulnS₂ Nanoparticles Capped with 1-Octanethiol (Cu:In = 1:0.75)

[0072] In(OAc)₃ (32.057 g, 120.0 mmol), Cu(OAc) (19.157 g, 156.3 mmol) and 240 mL of benzylether were mixed in a 1-L round-bottom flask fitted with a Liebig condenser and collector. The mixture was degassed at 100 °C for 90 minutes, then back-filled with N₂. Degassed 1-octanethiol (192 mL, 1.10 mol) was added and the mixture was heated to 200 °C and stirred for 2 hours, before being allowed to cool to 160 °C and left to stir for approximately 18 hours. The mixture was cooled to room temperature.

[0073] The nanoparticles were isolated in air, via the addition of solvents, followed by centrifugation.

[0074] Characterization of the nanoparticles by CPS disc centrifuge analysis (CPS Instruments Inc., Prairieville, Pennsylvania) revealed a particle size on the order of 3 nm.

Example 2: Synthesis of Copper-Rich CuInS₂ Nanoparticles Capped with 1-Octanethiol (Cu:In = 1:0.84)

[0075] In(OAc)₃ (3.995 g, 13.7 mmol) and Cu(OAc) (2.422 g, 19.8 mmol) were mixed in a 100 mL round-bottom flask fitted with a Liebig condenser and collector, purged with N₂. 30 mL of degassed benzylether were added, then the mixture was heated to $100\,^{\circ}$ C. Degassed 1-octanethiol (24 mL, 138 mmol) was added and the mixture was heated to $200\,^{\circ}$ C and stirred for 6 hours, before being allowed to cool to room temperature.

[0076] The nanoparticles were isolated in air, via the addition of solvents, followed by centrifugation.

Example 3: Synthesis of Copper-Rich CuInSe₂ Nanoparticles Capped with 1-Octane Selenol (Cu:In = 1:0.84)

[0077] 15 mL of 1-octadecene were degassed at approximately 110 °C for 45 minutes in a round-bottom flask fitted with a Liebig condenser and collector, then cooled to room temperature under N₂. Cu(OAc) (0.79 g, 6.4 mmol) and In(OAc)3 (1.54 g, 5.3 mmol) were added, then the mixture was degassed for a further 10 minutes at 140 °C. The mixture was cooled to room temperature. 1-Octane selenol (12 mL, 68 mmol) was added and the solution was heated. Acetic acid began to distill at 120 °C and was removed from the collector with a syringe. The solution was heated between 135 − 145 °C for 30 minutes to allow the remainder of the acetic acid to distill, then trioctylphosphine selenide (1.71 M, 8 mL, 14 mmol) was added over 10 minutes. The solution was stirred at 140 °C for 1 hour. The solution was cooled to 90 °C, then annealed for 4½ hours, before being cooled to room temperature.

[0078] The nanoparticles were isolated in air, via the addition of solvents, followed by centrifugation.

Example 4: Thin Film Prepared from Copper-Rich CulnS₂ Nanoparticles

[0079] Copper-rich CulnS₂ nanoparticles (Cu:ln = 1:0.76) capped with 1-octanethiol were dissolved in toluene to form a 200 mg/mL solution, $\bf B$.

[0080] An anode buffer layer of CulnS₂ was deposited on molybdenum-coated SLG substrates by spin coating, using a spin speed of 3000 rpm. The anode buffer layer was annealed at $270 \,^{\circ}$ C for 5 minutes and $415 \,^{\circ}$ C for 5 minutes to remove the ligand, yielding a layer thickness of ~ 50 nm.

[0081] The ink, **B**, was deposited on top of the anode buffer layer by spin coating, using a spin speed of 1500 rpm. The film was annealed at $270\,^{\circ}\text{C}$ for 5 minutes, then $415\,^{\circ}\text{C}$ for 5 minutes to remove the organic components of the ink formulation. The process was repeated four times further, until the film thickness was greater than 1 μ m.

[0082] The films were annealed under a selenium-rich atmosphere, using 2.18% by volume H₂Se in N₂, at 500 °C for 60 minutes.

[0083] Figure 4 compares the X-ray diffraction (XRD) pattern of the film, **401**, with that of a film prepared according the same procedure using near-stoichiometric CuInS₂ nanoparticles with a Cu:In ratio of 1:0.95, **402**. Analysis of the full-width at half-maximum (FWHM) of the (112) reflection shows a significantly narrower peak width for film prepared with the Cu-rich nanoparticles $(2\theta = 0.17^{\circ})$ compared to that prepared with near-stoichiometric nanoparticles $(2\theta = 0.36^{\circ})$. Since peak FWHM is inversely proportional to particle size, the results suggest that the Cu-rich nanoparticles promote grain growth.

Example 5: Thin Film Prepared from Copper-Rich CuInS₂ Nanoparticles with an Indium-Rich Buffer Layer

[0084] Copper-rich CuInS₂ nanoparticles (Cu:In = 1:0.85) capped with 1-octanethiol were dissolved in toluene to form an ink, \mathbf{C} .

[0085] A buffer layer of In-rich Cu(In,Ga)S₂ nanoparticles (Cu:In:Ga = 1:1.13:0.16) capped with 1-dodecanethiol was deposited on Mo-coated SLG substrates by spin coating, using a spin speed of 3000 rpm. The anode buffer layer was annealed at 270 °C for 5 minutes and 415 °C for 5 minutes to remove the ligand. The process was repeated once more.

[0086] The ink, \mathbf{C} , was deposited on top of the buffer layer by spin coating, using a spin speed of 3000 rpm. The film was annealed at 270 °C for 5 minutes, then 415 °C for 5 minutes to remove the organic components of the ink formulation. The process was repeated seven times, in order to achieve a total film thickness greater than 1 μ m.

[0087] The films were annealed under a selenium-rich atmosphere using 2.18% by volume H_2 Se in N_2 , at 500 °C for 60 minutes.

[0088] Figure 5 shows a scanning electron microscopy (SEM) image of the film. The CIGS layer, e.g., shows full crystallization, with grain sizes on the order of 1.1 µm.

[0089] Although particular embodiments of the present invention have been shown and described, they are not intended to limit what this patent covers. One skilled in the art will understand that various changes and modifications may be made without departing from the scope of the present invention as literally and equivalently covered by the following claims.

CLAIMS

What is claimed is:

1. A method for preparing CIGS nanoparticles comprising:

heating a copper salt together with at least one salt selected from the group consisting of indium salts and gallium salts in a solvent at a first temperature to produce a reaction solution;

adding an organo-chalcogen precursor to the reaction solution;

heating the reaction solution to a second temperature while stirring for a first time interval;

cooling the reaction solution to room temperature; and,

isolating nanoparticles from the reaction solution.

- 2. The method recited in claim 1 wherein the molar ratio of Cu salts to the combined total of In and Ga salts is between about 1:0.65 and about 1:0.85.
- 3. The method recited in claim 1 further comprising:
 - cooling the reaction solution to a third temperature and stirring for a second time interval after heating the reaction solution to a second temperature.
- 4. The method recited in claim 1 wherein the group consisting of copper salts, indium salts and gallium salts comprises salts selected from the group consisting of acetates, acetylacetonates, chlorides, bromides, and iodides.
- 5. The method recited in claim 1 wherein the solvent is a non-coordinating solvent.
- 6. The method recited in claim 5 wherein the non-coordinating solvent is selected from the group consisting of 1-octadecene, benzylether, diphenylether and heat transfer fluids comprising hydrogenated terphenyls.

7. The method recited in claim 1 wherein the first temperature is between room temperature and about 100 °C.

- 8. The method recited in claim 1 wherein the organo-chalcogen precursor is of the form R-X-H, where R is an alkyl or aryl group and X is sulfur or selenium.
- 9. The method recited in claim 1 wherein the organo-chalcogen precursor is selected from the group consisting of 1-octanethiol, 1-octane selenol, and 1-dodecane selenol.
- 10. The method recited in claim 1 wherein the second temperature is higher than the first temperature.
- 11. The method recited in claim 10 wherein second temperature is between about 160 ℃ and about 240 ℃.
- 12. The method recited in claim 1 further comprising annealing the reaction solution at a temperature below the second temperature for a period between about 4 hours and about 24 hours.
- 13. The method recited in claim 1 wherein isolating the nanoparticles comprises precipitating the nanoparticles from solution by the addition of at least one other solvent.
- 14. CIGS nanoparticles prepared by the process comprising the steps of:
 - heating a copper salt together with at least one salt selected from the group consisting of indium salts and gallium salts in a solvent at a first temperature to produce a reaction solution;

adding an organo-chalcogen precursor to the reaction solution;

heating the reaction solution to a second temperature while stirring for a first time interval;

cooling the reaction solution to room temperature; and,

isolating nanoparticles from the reaction solution.

15. CIGS nanoparticles as recited in claim 14 wherein the molar ratio of Cu salts to the combined total of In and Ga salts is between about 1:0.65 and about 1:0.85.

- 16. CIGS nanoparticles as recited in claim 14 wherein the preparation process further comprises:
 - cooling the reaction solution to a third temperature and stirring for a second time interval after heating the reaction solution to a second temperature.
- 17. A method for preparing CIGS nanoparticles comprising:
 - mixing salts selected from the group consisting of copper salts, indium salts and gallium salts in a solvent at a first temperature to produce a reaction solution;
 - adding an organo-chalcogen precursor to the reaction solution;
 - heating the reaction solution to a first temperature while stirring for a first time interval;
 - heating the reaction solution to a second temperature and adding a second chalcogen precursor over a second time interval;
 - stirring the reaction solution at the second temperature for a third time interval;
 - cooling the reaction solution to a third temperature and stirring for a fourth time interval;
 - cooling the reaction solution to room temperature; and, isolating the nanoparticles.
- 18. The method recited in claim 17 wherein the molar ratio of Cu salts to the combined total of In and Ga salts is between about 1:0.65 and about 1:0.85.

19. The method recited in claim 17 wherein the group consisting of copper salts, indium salts and gallium salts comprises salts selected from the group consisting of acetates, acetylacetonates, chlorides, bromides, and iodides.

- 20. The method recited in claim 17 wherein the solvent is a non-coordinating solvent.
- 21. The method recited in claim 20 wherein the non-coordinating solvent is selected from the group consisting of 1-octadecene, benzylether, diphenylether and heat transfer fluids comprising hydrogenated terphenyls.
- 22. The method recited in claim 17 wherein the organo-chalcogen precursor is of the form R-X-H, where R is an alkyl or aryl group and X is sulfur or selenium.
- 23. The method recited in claim 17 wherein the organo-chalcogen precursor has a boiling point below about 250 ℃.
- 24. The method recited in claim 22 wherein the organo-chalcogen precursor is selected from the group consisting of 1-octanethiol, 1-octane selenol, and 1-dodecane selenol.
- 25. The method recited in claim 17 wherein the first time interval is sufficient to effect distillation of substantially all volatile by-products.
- 26. The method recited in claim 17 wherein the second temperature is between about 120 °C and about 160 °C.
- 27. The method recited in claim 17 wherein the second chalcogen precursor comprises an elemental chalcogen dissolved in a coordinating solvent.
- 28. The method recited in claim 27 wherein the coordinating solvent is selected from the group consisting of trioctylphosphine sulfide and trioctylphosphine selenide.
- 29. The method recited in claim 17 wherein second temperature is between about 120 ℃ and about 160 ℃.
- 30. The method recited in claim 17 wherein the third time interval is between about 30 minutes about 2 hours.

31. The method recited in claim 17 wherein third temperature is between about 80 ℃ and about 120 ℃.

- 32. The method recited in claim 17 wherein the fourth time interval is between about 3 hours and about 6 hours.
- 33. The method recited in claim 17 wherein isolating the nanoparticles comprises precipitating the nanoparticles from solution by the addition of at least one other solvent.
- 34. CIGS nanoparticles prepared by the process comprising the steps of:
 - mixing salts selected from the group consisting of copper salts, indium salts and gallium salts in a solvent at a first temperature to produce a reaction solution;
 - adding an organo-chalcogen precursor to the reaction solution;
 - heating the reaction solution to a first temperature while stirring for a first time interval;
 - heating the reaction solution to a second temperature and adding a second chalcogen precursor over a second time interval;
 - stirring the reaction solution at the second temperature for a third time interval;
 - cooling the reaction solution to a third temperature and stirring for a fourth time interval;
 - cooling the reaction solution to room temperature; and, isolating the nanoparticles.
- 35. CIGS nanoparticles as recited in claim 34 wherein the molar ratio of Cu salts to the combined total of In and Ga salts is between about 1:0.65 and about 1:0.85.

36. A CIGS-based photovoltaic device prepared by the process comprising the steps of:

- a. mixing nanoparticles in a solvent to form an ink;
- b. depositing the ink on a substrate to form a film;
- c. annealing the film in an inert atmosphere to produce an annealed film;
- d. repeating steps b and c until the annealed film obtains a preselected thickness;
- e. depositing an *n*-type semiconductor layer on the annealed film to form a junction;
- f. depositing intrinsic ZnO on the junction to form an extended depletion layer;
- g. depositing a window layer on the extended depletion layer;
- h. depositing a metal grid on the window layer to form an assembly; and,
- i. encapsulating the assembly to form a photovoltaic device.
- 37. The CIGS-based photovoltaic device as recited in claim 36 wherein the process of preparation further comprises:
 - performing at least one further film processing step subsequent to step d selected from the group of film processing steps consisting of annealing, sintering, selenization, and etching with KCN.
- 38. The CIGS-based photovoltaic device as recited in claim 36 wherein the nanoparticles are selected from the group consisting of ternary, quaternary and quinary chalcogenides of the form $Culn_wGa_xSe_yS_z$, where $0 \le w$, x < 1, w + x < 1, $y, z \ge 0$ and $y + z \approx 2$, including doped species, alloys and combinations thereof.
- 39. The CIGS-based photovoltaic device as recited in claim 36 wherein $0.7 \le w + x < 1$.
- 40. The CIGS-based photovoltaic device as recited in claim 36 wherein the nanoparticles are soluble in the solvent.

41. The CIGS-based photovoltaic device as recited in claim 36 wherein the nanoparticles are dispersible in the solvent.

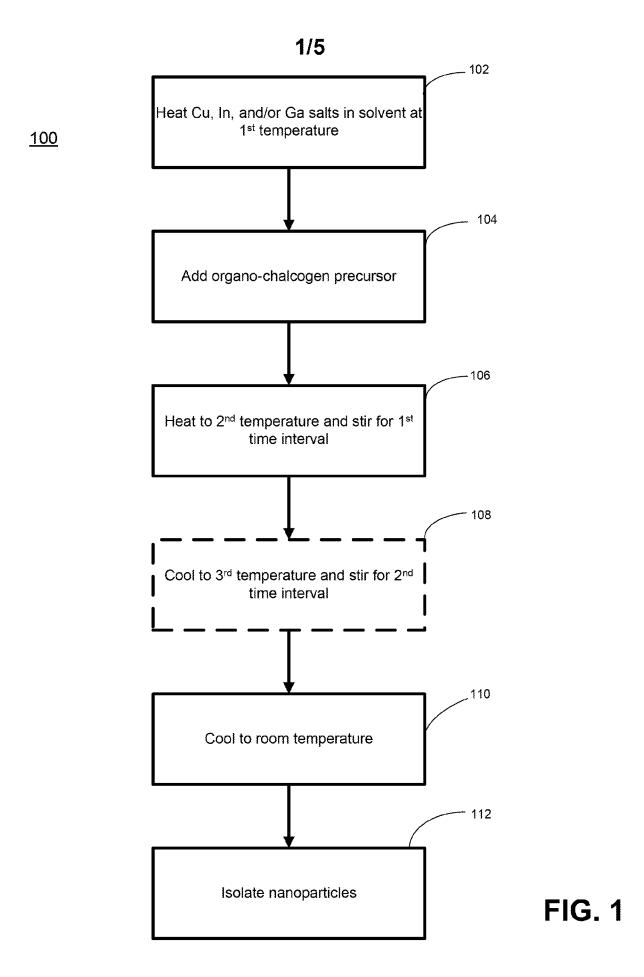
- 42. The CIGS-based photovoltaic device as recited in claim 36 wherein the solvent is selected from the group consisting of toluene, alkanes, dichloromethane, chloroform, isophorone, anisole, α-terpinene and, limonene.
- 43. The CIGS-based photovoltaic device as recited in claim 36 wherein the ink additionally comprises oleic acid at a concentration between about 2 5 wt. % of the total ink formulation.
- 44. The CIGS-based photovoltaic device as recited in claim 36 wherein the substrate is selected from the group consisting of indium tin oxide (ITO), molybdenum-coated bare glass, and molybdenum-coated soda-lime glass (SLG).
- 45. The CIGS-based photovoltaic device as recited in claim 36 wherein steps b and c are repeated until the CIGS film thickness is at least 1 µm.
- 46. The CIGS-based photovoltaic device as recited in claim 36 wherein at least one buffer layer is deposited onto the substrate and processed prior to the deposition of the ink.
- 47. The CIGS-based device as recited in claim 46 wherein the at least one buffer layer comprises CIGS nanoparticles having a stoichiometry different from that of the nanoparticles used to formulate the ink.
- 48. The CIGS-based device as recited in claim 47 wherein the ratio of copper to indium (Cu/In) is less than one.
- 49. The CIGS-based device as recited in claim 46 wherein the thickness of the buffer layer is \leq 100 nm.
- 50. The CIGS-based device as recited in claim 36 wherein the film is annealed at a first, lower temperature between about $250 \,^{\circ}\text{C} 300 \,^{\circ}\text{C}$ for between about 3 7 minutes then subsequently annealed at a second, higher temperature between about $400 \,^{\circ}\text{C} 430 \,^{\circ}\text{C}$ for between about 3 7 minutes.

51. The CIGS-based photovoltaic device as recited in claim 36 wherein the process of preparation further comprises:

- performing at least one further film processing step subsequent to step d comprising a sulfurization process, during which the CIGS film is annealed in a sulfur-rich atmosphere.
- 52. The CIGS-based photovoltaic device as recited in claim 51 wherein the sulfur-rich atmosphere is provided by H₂S gas in an inert carrier gas.
- 53. The CIGS-based photovoltaic device as recited in claim 36 wherein the process of preparation further comprises:
 - performing at least one further film processing step subsequent to step d comprising a selenization process, during which the CIGS film is annealed in a selenium-rich atmosphere.
- 54. The CIGS-based photovoltaic device as recited in claim 53 wherein the selenium-rich atmosphere is provided by H₂Se gas in an inert carrier gas.
- 55. The CIGS-based photovoltaic device as recited in claim 53 wherein the selenization process effects conversion of excess copper in the CIGS nanoparticles to copper selenide.
- 56. The CIGS-based photovoltaic device as recited in claim 53 wherein the selenization process also effects at least a partial conversion of a CuInS₂ layer to CuInSe₂.
- 57. The CIGS-based device as recited in claim 36 wherein the process of preparation further comprise etching of the CIGS film in a KCN solution to selectively remove excess copper selenide and/or copper sulfide phases from the CIGS absorber layer.
- 58. The CIGS-based device as recited in claim 36 wherein the *n*-type semiconductor layer comprises a material selected from the group consisting of CdS, Zn(O,S), ZnO and ZnS.

59. The CIGS-based device as recited in claim 36 wherein the window layer consists of a material selected from the group consisting of aluminum zinc oxide (AZO) and boron-doped zinc oxide.

- 60. The CIGS-based device as recited in claim 36 wherein the window layer consists of indium tin oxide (ITO).
- 61. The CIGS-based device as recited in claim 36 wherein the nanoparticles are nanoparticles according to claim 14.
- 62. The CIGS-based device as recited in claim 36 wherein the nanoparticles are nanoparticles according to claim 34.



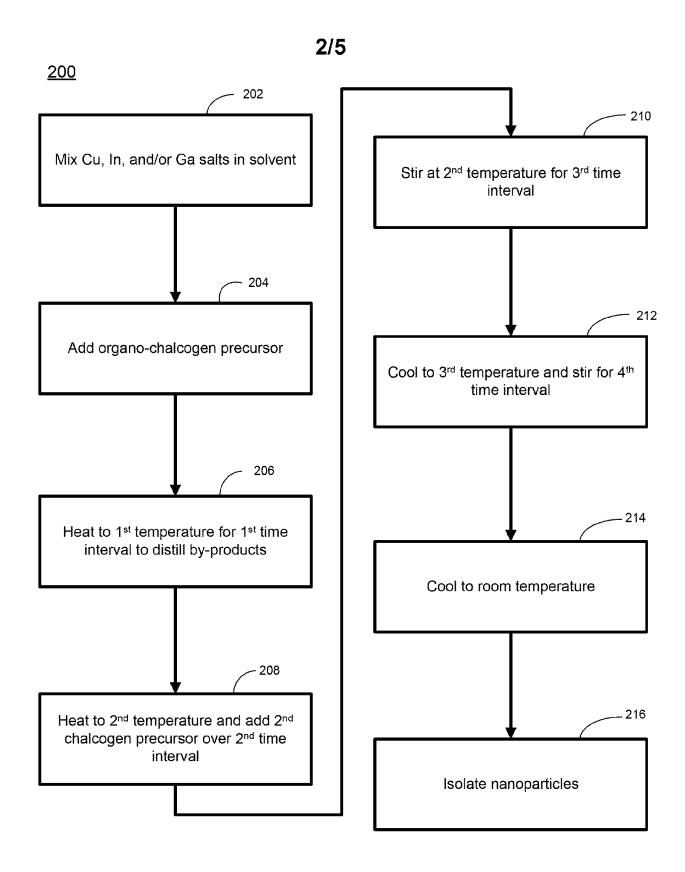


FIG. 2

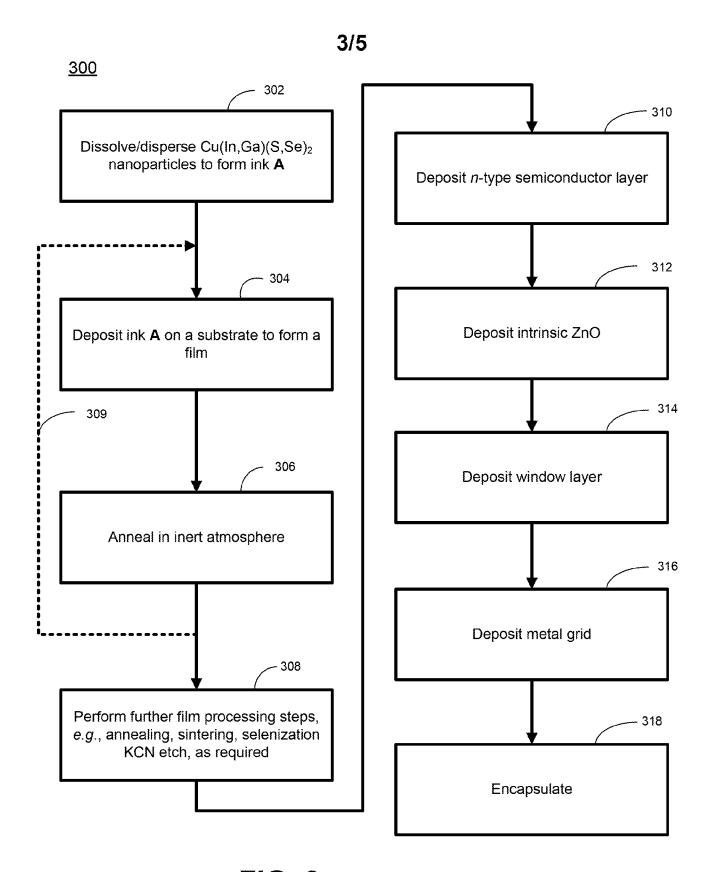


FIG. 3

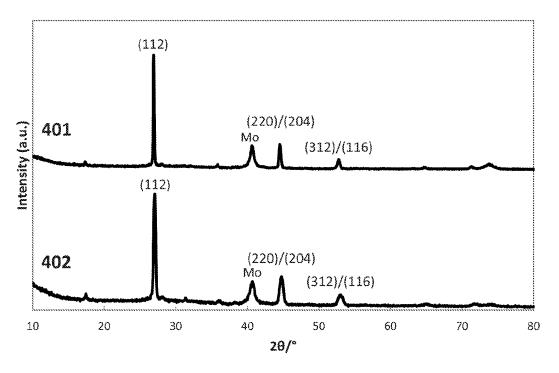


FIG. 4

5/5

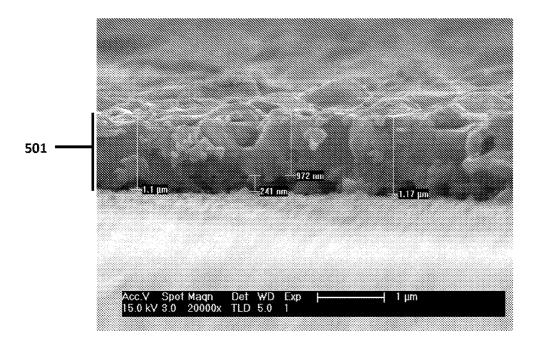


FIG. 5

International application No PCT/GB2014/053371

A. CLASSIFICATION OF SUBJECT MATTER INV. C01G15/00 B82Y30/00

INV. C01G15/00 H01L31/0352 B82Y30/00 H01L31/0749 C01B19/00 H01L31/0445 H01L31/00

H01L31/032

ADD.

According to International Patent Classification (IPC) or to both national classification and IPC

B. FIELDS SEARCHED

Minimum documentation searched (classification system followed by classification symbols)

C01G B82Y C01B H01L

Documentation searched other than minimum documentation to the extent that such documents are included in the fields searched

Electronic data base consulted during the international search (name of data base and, where practicable, search terms used)

EPO-Internal, WPI Data

C. DOCUMENTS CONSIDERED TO BE RELEVANT				
Category*	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.		
X Y	US 2008/257201 A1 (HARRIS JAMES [GB] ET AL) 23 October 2008 (2008-10-23) examples 1,2	1,3-14, 16,17, 19-34 2,15,18, 35,61,62		
X	US 2009/139574 A1 (PICKETT NIGEL [GB] ET AL) 4 June 2009 (2009-06-04) cited in the application	1,4-14, 16		
Υ	paragraphs [0075] - [0089]; examples 1,2	2,15,18, 35		
Α		3,17, 19-34		
	-/			

Χ	Further documents are listed in the	continuation of Box C.
---	-------------------------------------	------------------------

X See patent family annex.

- * Special categories of cited documents :
- "A" document defining the general state of the art which is not considered to be of particular relevance
- "E" earlier application or patent but published on or after the international filing date
- "L" document which may throw doubts on priority claim(s) or which is cited to establish the publication date of another citation or other special reason (as specified)
- "O" document referring to an oral disclosure, use, exhibition or other
- "P" document published prior to the international filing date but later than the priority date claimed
- "T" later document published after the international filing date or priority date and not in conflict with the application but cited to understand the principle or theory underlying the invention
- "X" document of particular relevance; the claimed invention cannot be considered novel or cannot be considered to involve an inventive step when the document is taken alone
- "Y" document of particular relevance; the claimed invention cannot be considered to involve an inventive step when the document is combined with one or more other such documents, such combination being obvious to a person skilled in the art
- "&" document member of the same patent family

15/04/2015

Date of the actual completion of the international search

Date of mailing of the international search report

8 April 2015

Name and mailing address of the ISA/

European Patent Office, P.B. 5818 Patentlaan 2

NL - 2280 HV Rijswijk

Tel. (+31-70) 340-2040,

Fax: (+31-70) 340-3016

Authorized officer

Nobis, Barbara

International application No. PCT/GB2014/053371

INTERNATIONAL SEARCH REPORT

Box No. II Observations where certain claims were found unsearchable (Continuation of item 2 of first sheet)				
This international search report has not been established in respect of certain claims under Article 17(2)(a) for the following reasons:				
Claims Nos.: because they relate to subject matter not required to be searched by this Authority, namely:				
2. Claims Nos.: because they relate to parts of the international application that do not comply with the prescribed requirements to such an extent that no meaningful international search can be carried out, specifically:				
3. Claims Nos.: because they are dependent claims and are not drafted in accordance with the second and third sentences of Rule 6.4(a).				
Box No. III Observations where unity of invention is lacking (Continuation of item 3 of first sheet)				
This International Searching Authority found multiple inventions in this international application, as follows:				
see additional sheet				
1. X As all required additional search fees were timely paid by the applicant, this international search report covers all searchable claims.				
2. As all searchable claims could be searched without effort justifying an additional fees, this Authority did not invite payment of additional fees.				
3. As only some of the required additional search fees were timely paid by the applicant, this international search report covers only those claims for which fees were paid, specifically claims Nos.:				
4. No required additional search fees were timely paid by the applicant. Consequently, this international search report is restricted to the invention first mentioned in the claims; it is covered by claims Nos.:				
The additional search fees were accompanied by the applicant's protest and, where applicable, the payment of a protest fee. The additional search fees were accompanied by the applicant's protest but the applicable protest fee was not paid within the time limit specified in the invitation.				
No protest accompanied the payment of additional search fees.				

FURTHER INFORMATION CONTINUED FROM PCT/ISA/ 210

This International Searching Authority found multiple (groups of) inventions in this international application, as follows:

1. claims: 1-35

Method for preparing CIGS nanoparticles, and CIGS nanoparticles

2. claims: 36-62

CIGS-based photovoltaic device

International application No
PCT/GB2014/053371

C(Continuation). DOCUMENTS CONSIDERED TO BE RELEVANT				
Category*	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.		
Y	JIANG TANG ET AL: "Synthesis of Colloidal CuGaSe2, CuInSe2, and Cu(InGa)Se2 Nanoparticles", CHEMISTRY OF MATERIALS, AMERICAN CHEMICAL SOCIETY, US, vol. 20, no. 22, 25 November 2008 (2008-11-25), pages 6906-6910, XP008162012, ISSN: 0897-4756 table 1	2,15,18, 35		
Y	Ming Li ET AL: "Fabrication and characterization of ordered CuIn (1-x) Ga x Se 2 nanopore films via template-based electrodeposition Background", Nanoscale Research Letters, 1 January 2012 (2012-01-01), pages 1-6, XP055163393, D0I: 10.1186/1556-276X-7-675 Retrieved from the Internet: URL:http://www.nanoscalereslett.com/content/7/1/675 [retrieved on 2015-01-20] table 1	2,15,18,		
X,P	US 2014/249324 A1 (HARRIS JAMES [GB] ET AL) 4 September 2014 (2014-09-04) cited in the application examples 7,9	1-35		
X Y	US 2005/072461 A1 (KUCHINSKI FRANK [US] ET AL) 7 April 2005 (2005-04-07) paragraphs [0003], [0045], [0046], [0059] - [0062]; claims; example 1	36-60 61,62		
X Y	US 2012/313200 A1 (JACKREL DAVID B [US] ET AL) 13 December 2012 (2012-12-13) paragraphs [0092], [0158] - [0161], [0201] - [0203], [0322]; claims	36-60 61,62		
X Y	US 2007/093006 A1 (BASOL BULENT M [US]) 26 April 2007 (2007-04-26) paragraphs [0004], [0005], [0011], [0019], [0047], [0051]; claims	36-60 61,62		

International application No
PCT/GB2014/053371

Relevant to claim No.
36-60
61,62
36-60 61,62

Information on patent family members

International application No
PCT/GB2014/053371

Patent document cited in search report	Publication date	Patent family member(s)	Publication date
US 2008257201 A1	23-10-2008	TW 200908359 A US 2008257201 A1 US 2010212544 A1	16-02-2009 23-10-2008 26-08-2010
US 2009139574 A1	04-06-2009	US 2009139574 A1 US 2014319433 A1	04-06-2009 30-10-2014
US 2014249324 A1	04-09-2014	US 2014249324 A1 WO 2014135979 A1	04-09-2014 12-09-2014
US 2005072461 A1	07-04-2005	US 2005072461 A1 WO 2005006393 A2	07-04-2005 20-01-2005
US 2012313200 A1	13-12-2012	CN 103959436 A JP 2014524145 A KR 20140082636 A TW 201324826 A US 2012313200 A1 WO 2013003439 A1	30-07-2014 18-09-2014 02-07-2014 16-06-2013 13-12-2012 03-01-2013
US 2007093006 A1	26-04-2007	CN 101443920 A US 2007093006 A1 US 2010229940 A1 WO 2007108932 A2	27-05-2009 26-04-2007 16-09-2010 27-09-2007